## PSMN4R4-80PS

# N-channel 80 V, 4.1 mΩ standard level FET

Rev. 01 — 18 June 2009

**Product data sheet** 

### 1. Product profile

### 1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. This product is designed and qualified for use in computing, communications, consumer and industrial applications only.

#### 1.2 Features and benefits

- Low conduction losses due to low on-state resistance
- Suitable for standard level gate drive sources

### 1.3 Applications

- DC DC converters
- Load switch

- Motor control
- Server power supplies

#### 1.4 Quick reference data

Table 1. Quick reference

| Symbol            | Parameter                           | Conditions  |     | Min | Тур | Max | Unit |
|-------------------|-------------------------------------|---|-----|-----|-----|-----|------|
| $I_D$             | drain current                       | $T_{mb}$ = 25 °C; $V_{GS}$ = 10 V;<br>see <u>Figure 1</u> ; see <u>Figure 3</u>                   |     | -   | -   | 100 | Α    |
| P <sub>tot</sub>  | total power dissipation             | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>  |     | -   | -   | 306 | W    |
| Dynamic           | characteristics                     |   |     |     |     |     |      |
| $Q_{GD}$          | gate-drain charge                   | $V_{GS}$ = 10 V; $I_D$ = 80 A;<br>$V_{DS}$ = 40 V; see <u>Figure 14</u> ;<br>see <u>Figure 15</u> |     | -   | 25  | -   | nC   |
| Static ch         | aracteristics                       |   |     |     |     |     |      |
| R <sub>DSon</sub> | drain-source<br>on-state resistance | $V_{GS}$ = 10 V; $I_D$ = 15 A;<br>$T_j$ = 25 °C; see <u>Figure 6</u> ;<br>see <u>Figure 13</u>    | [1] | -   | 3.3 | 4.1 | mΩ   |

<sup>[1]</sup> Measured 3 mm from package.



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N-channel 80 V, 4.1 m $\Omega$  standard level FET

### **Pinning information**

Table 2. **Pinning information** 

| Pin | Symbol | Description | Simplified outline         | Graphic symbol        |
|-----|--------|-------------|----------------------------|-----------------------|
| 1   | G      | gate        |                            | _                     |
| 2   | D      | drain       | mb                         | D                     |
| 3   | S      | source      |                            | $G \longrightarrow A$ |
| mb  | D      | drain       | 1 2 3                      | mbb076 S              |
|     |        |             | SOT78<br>(TO-220AB; SC-46) |                       |

#### **Ordering information** 3.

Table 3. **Ordering information** 

**Product data sheet** 

| Type number  | Package            |  |         |  |  |  |
|--------------|--------------------|--|---------|--|--|--|
|              | Name               | Description  | Version |  |  |  |
| PSMN4R4-80PS | TO-220AB;<br>SC-46 | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB | SOT78   |  |  |  |

### 4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol               | Parameter  | Conditions  | Min | Max | Unit |
|----------------------|--|---|-----|-----|------|
| $V_{DS}$             | drain-source voltage                               | $T_j \ge 25 ^{\circ}\text{C}; T_j \le 175 ^{\circ}\text{C}$   | -   | 80  | V    |
| $V_{DGR}$            | drain-gate voltage                                 | $T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$                        | -   | 80  | V    |
| $V_{GS}$             | gate-source voltage                                |   | -20 | 20  | V    |
| I <sub>D</sub>       | drain current                                      | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 100 °C; see <u>Figure 1</u> ;<br>see <u>Figure 3</u>      | -   | 100 | Α    |
|                      |  | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; see <u>Figure 1</u> ; see <u>Figure 3</u>          | -   | 100 | Α    |
| I <sub>DM</sub>      | peak drain current                                 | $t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$ ; see Figure 3                             | -   | 680 | Α    |
| P <sub>tot</sub>     | total power dissipation                            | T <sub>mb</sub> = 25 °C; see <u>Figure 2</u>  | -   | 306 | W    |
| T <sub>stg</sub>     | storage temperature                                |   | -55 | 175 | °C   |
| Tj                   | junction temperature                               |   | -55 | 175 | °C   |
| Source-dr            | ain diode  |   |     |     |      |
| Is                   | source current                                     | T <sub>mb</sub> = 25 °C   | -   | 100 | Α    |
| I <sub>SM</sub>      | peak source current                                | $t_p \le 10 \ \mu s$ ; pulsed; $T_{mb} = 25 \ ^{\circ}C$  | -   | 680 | Α    |
| Avalanche            | ruggedness   |   |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive<br>drain-source avalanche<br>energy | $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; $I_D$ = 100 A; $V_{sup}$ ≤ 80 V; $R_{GS}$ = 50 Ω; unclamped | -   | 591 | mJ   |

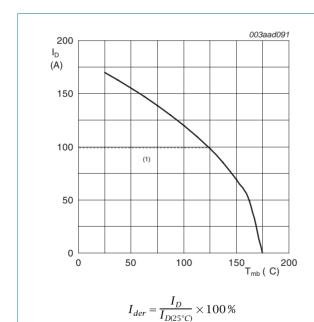
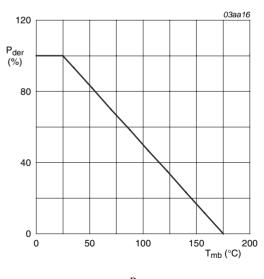
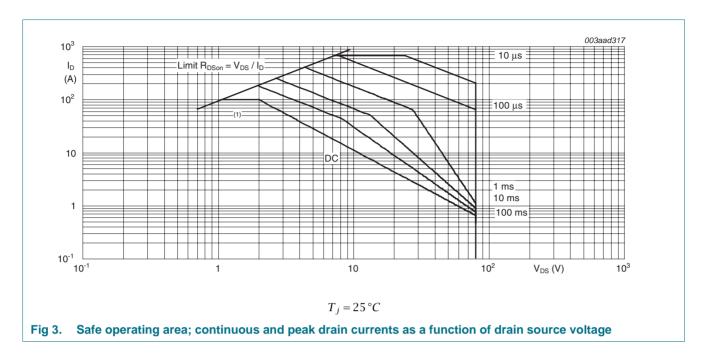


Fig 1. Normalized continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

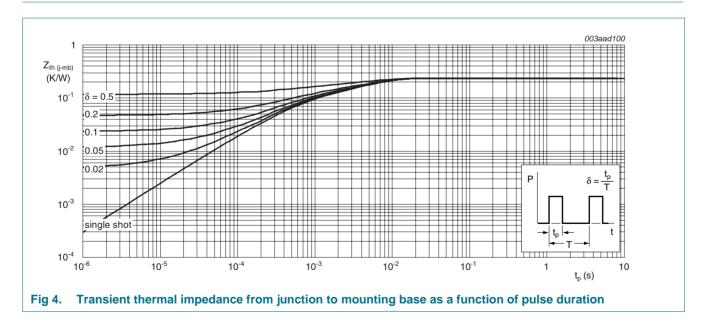
Fig 2. Normalized total power dissipation as a function of mounting base temperature



### 5. Thermal characteristics

Table 5. Thermal characteristics

| Symbol         | Parameter   | Conditions   | Min | Тур  | Max  | Unit |
|----------------|---|--------------|-----|------|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | see Figure 4 | -   | 0.23 | 0.49 | K/W  |



### 6. Characteristics

Table 6. Characteristics

| Table 6.                                  | Characteristics                      |   |     |     |      |      |      |
|---|--------------------------------------|---|-----|-----|------|------|------|
| Symbol                                    | Parameter                            | Conditions  |     | Min | Тур  | Max  | Unit |
| Static cha                                | racteristics                         |   |     |     |      |      |      |
| $V_{(BR)DSS}$                             | drain-source                         | $I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^{\circ}C$  |     | 73  | -    | -    | V    |
|   | breakdown voltage                    | $I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$   |     | 80  | -    | -    | V    |
| $V_{GS(th)}$                              | gate-source threshold voltage        | $I_D = 1 \text{ mA}$ ; $V_{DS} = V_{GS}$ ; $T_j = 175 \text{ °C}$ ; see Figure 11                                     |     | 1   | -    | -    | V    |
|   |                                      | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = -55$ °C; see Figure 11   |     | -   | -    | 4.6  | V    |
|   |                                      | $I_D = 1$ mA; $V_{DS} = V_{GS}$ ; $T_j = 25$ °C;<br>see <u>Figure 11</u> ; see <u>Figure 12</u>                       |     | 2   | 3    | 4    | V    |
| I <sub>DSS</sub>                          | drain leakage current                | $V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$  |     | -   | -    | 10   | μΑ   |
|   |                                      | $V_{DS} = 80 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ °C}$   |     | -   | -    | 200  | μΑ   |
| $I_{GSS}$                                 | gate leakage current                 | $V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$   |     | -   | -    | 100  | nA   |
|   |                                      | $V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$  |     | -   | -    | 100  | nΑ   |
| R <sub>DSon</sub> drain-source resistance | drain-source on-state resistance     | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 175 \text{ °C};$<br>see Figure 13                                   | [2] | -   | 7.6  | 9.47 | mΩ   |
|   |                                      | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 100 \text{ °C};$<br>see Figure 13                                   |     | -   | 5.5  | 6.8  | mΩ   |
|   |                                      | $V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 \text{ °C};$<br>see Figure 6; see Figure 13                      | [2] | -   | 3.3  | 4.1  | mΩ   |
| $R_{G}$                                   | internal gate resistance (AC)        | f = 1 MHz   |     | -   | 1    | -    | Ω    |
| Dynamic (                                 | characteristics                      |   |     |     |      |      |      |
| Q <sub>G(tot)</sub>                       | total gate charge                    | $I_D = 0 \text{ A}; V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}$  |     | -   | 112  | -    | nC   |
|   |                                      | I <sub>D</sub> = 80 A; V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 10 V;<br>see <u>Figure 14</u> ; see <u>Figure 15</u> |     | -   | 125  | -    | nC   |
| Q <sub>GS</sub>                           | gate-source charge                   | $I_D = 80 \text{ A}; V_{DS} = 40 \text{ V}; V_{GS} = 10 \text{ V};$   |     | -   | 39   | -    | nC   |
| Q <sub>GS(th)</sub>                       | pre-threshold<br>gate-source charge  | see <u>Figure 14</u> ; see <u>Figure 15</u>   |     | -   | 24   | -    | nC   |
| Q <sub>GS(th-pl)</sub>                    | post-threshold<br>gate-source charge |   |     | -   | 15   | -    | nC   |
| $Q_{GD}$                                  | gate-drain charge                    |   |     | -   | 25   | -    | nC   |
| $V_{GS(pl)}$                              | gate-source plateau voltage          | $I_D = 25 \text{ A}$ ; $V_{DS} = 40 \text{ V}$ ; see <u>Figure 14</u> ; see <u>Figure 15</u>                          |     | -   | 4.65 | -    | V    |
| C <sub>iss</sub>                          | input capacitance                    | V <sub>DS</sub> = 40 V; V <sub>GS</sub> = 0 V; f = 1 MHz;   |     | -   | 8400 | -    | pF   |
| C <sub>oss</sub>                          | output capacitance                   | T <sub>j</sub> = 25 °C; see <u>Figure 16</u>  |     | -   | 700  | -    | pF   |
| C <sub>rss</sub>                          | reverse transfer capacitance         |   |     | -   | 336  | -    | pF   |
| t <sub>d(on)</sub>                        | turn-on delay time                   | $V_{DS} = 40 \text{ V}; R_L = 0.5 \Omega; V_{GS} = 10 \text{ V};$   |     | -   | 34.7 | -    | ns   |
| t <sub>r</sub>                            | rise time                            | $R_{G(ext)} = 1.5 \Omega$   |     | -   | 38.1 | -    | ns   |
| t <sub>d(off)</sub>                       | turn-off delay time                  |   |     | -   | 66   | -    | ns   |
| t <sub>f</sub>                            | fall time                            |   |     | -   | 18.4 | -    | ns   |
|   |                                      |   |     |     |      |      |      |

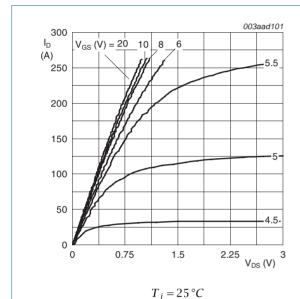
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Table 6. Characteristics ... continued

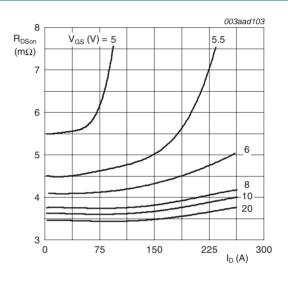
| Symbol             | Parameter             | Conditions  | Min | Тур | Max | Unit |
|--------------------|-----------------------|---|-----|-----|-----|------|
| Source-drain diode |                       |   |     |     |     |      |
| $V_{SD}$           | source-drain voltage  | $I_S = 25 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C};$<br>see <u>Figure 17</u>                  | -   | 0.8 | 1.2 | V    |
| t <sub>rr</sub>    | reverse recovery time | $I_S = 25 \text{ A}$ ; $dI_S/dt = 100 \text{ A/}\mu\text{s}$ ; $V_{GS} = 0 \text{ V}$ ; $V_{DS} = 20 \text{ V}$ | -   | 59  | -   | ns   |
| Q <sub>r</sub>     | recovered charge      |   | -   | 130 | -   | nC   |

- [1] Tested to JEDEC standards where applicable.
- [2] Measured 3 mm from package.



 $I_j - 23$  C

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



 $T_j = 25 \,^{\circ}C; I_D = 15A$ 

Fig 6. Drain-source on-state resistance as a function of drain current; typical values

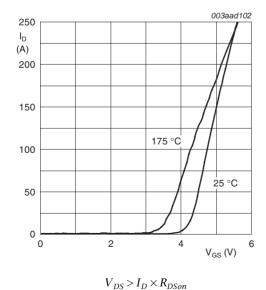
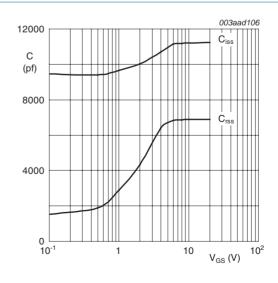
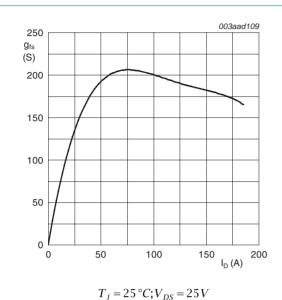


Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values

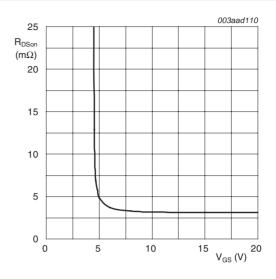


 $V_{DS}=0\,V; f=1MHz$ 

Fig 8. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

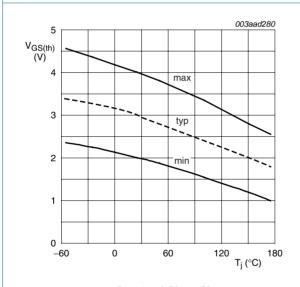


Forward transconductance as a function of Fig 9. drain current; typical values



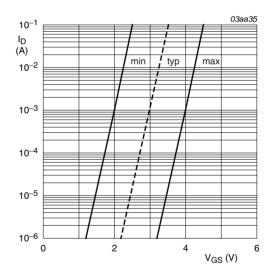
 $T_j = 25 \,^{\circ}C; I_D = 15A$ 

Fig 10. Drain-source on-state resistance as a function of gate-source voltage; typical values



 $I_D = 1 \, mA; V_{DS} = V_{GS}$ Fig 11. Gate-source threshold voltage as a function of

junction temperature



$$T_i = 25 \,^{\circ}C; V_{DS} = 5V$$

Fig 12. Sub-threshold drain current as a function of gate-source voltage

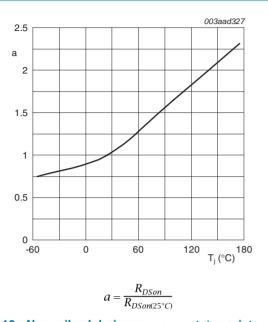


Fig 13. Normailzed drain-source on-state resistance factor as a function of junction temperature

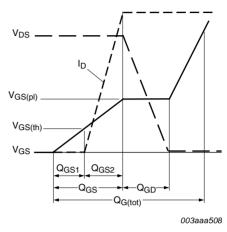


Fig 14. Gate charge waveform definitions

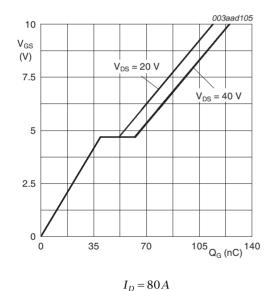


Fig 15. Gate-source voltage as a function of gate charge; typical values

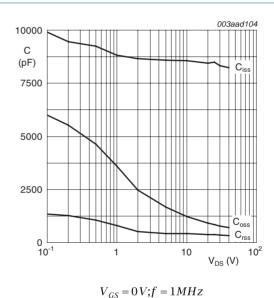
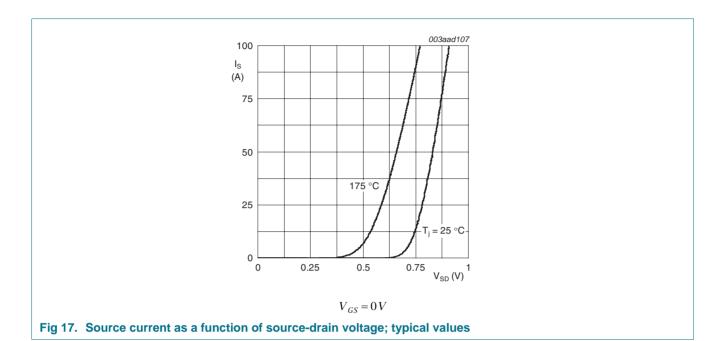


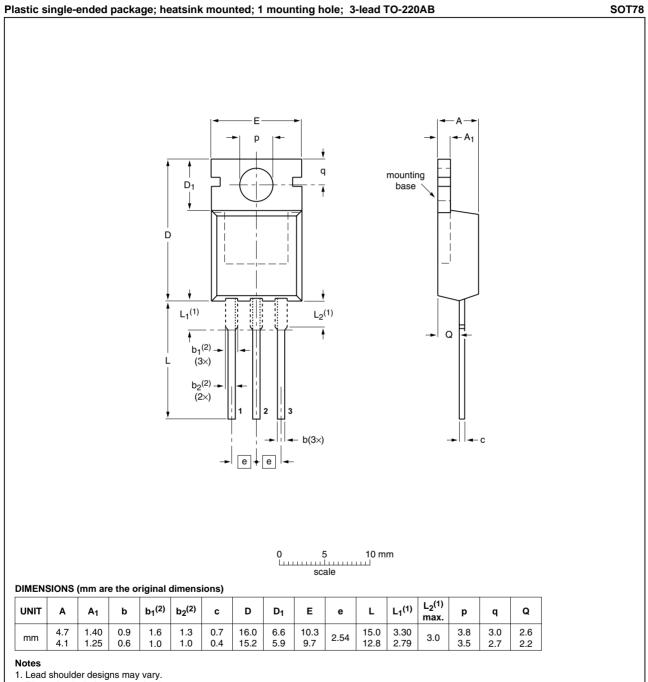
Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

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### 7. Package outline



2. Dimension includes excess dambar.

| OUTLINE |     | REFER           | ENCES | EUROPEAN   |                                 |
|---------|-----|-----------------|-------|------------|---------------------------------|
| VERSION | IEC | JEDEC           | JEITA | PROJECTION | ISSUE DATE                      |
| SOT78   |     | 3-lead TO-220AB | SC-46 |            | <del>08-04-23</del><br>08-06-13 |

Fig 18. Package outline SOT78 (TO-220AB)

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### 8. Revision history

### Table 7. Revision history

| Document ID    | Release date | Data sheet status  | Change notice | Supersedes |
|----------------|--------------|--------------------|---------------|------------|
| PSMN4R4-80PS_1 | 20090618     | Product data sheet | -             | -          |

#### N-channel 80 V, 4.1 mΩ standard level FET

### 9. Legal information

#### 9.1 Data sheet status

| Document status [1][2]         | Product status[3] | Definition  |
|--------------------------------|-------------------|---|
| Objective [short] data sheet   | Development       | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification     | This document contains data from the preliminary specification.                       |
| Product [short] data sheet     | Production        | This document contains the product specification.                                     |

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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## PSMN4R4-80PS

### N-channel 80 V, 4.1 m $\Omega$ standard level FET

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